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Octal D-type Transparent Latches with 3-state Outputs



ADE-205-070B(Z)

Rev.2 September 1995

Description

The HD74LVC533 has eight D type latches with three state outputs in a 20 pin package. When the latch enable input is high, the Q outputs will follow the D inputs. When the latch enable goes low, data at the D inputs will be retained at the outputs until latch enable returns high again. When a high logic level is applied to the output control input, all outputs go to a high impedance state, regardless of what signals are present at the other inputs and the state of the storage elements. Low voltage and high speed operation is suitable at the battery drive product (note type personal computer) and low power consumption extends the life of a battery for long time operation.

Features

- $V_{cc} = 2.0 \text{ V to } 5.5 \text{ V}$
- All inputs V_{H} (Max.) = 5.5 V (@ V_{CC} = 0 V to 5.5 V)
- Typical V_{OL} ground bounce < 0.8 V (@ V_{CC} = 3.3 V, Ta = 25°C)
- Typical V_{OH} undershoot > 2.0 V (@ V_{CC} = 3.3 V, Ta = 25°C)
- High output current ± 24 mA (@V_{cc} = 3.0 V to 5.5 V)

Function Table

Inputs

G	LE	D	Output Q
Н	X	X	Z
L	Н	L	Н
L	Н	Н	L
L	L	X	Q_{0}

H: High level

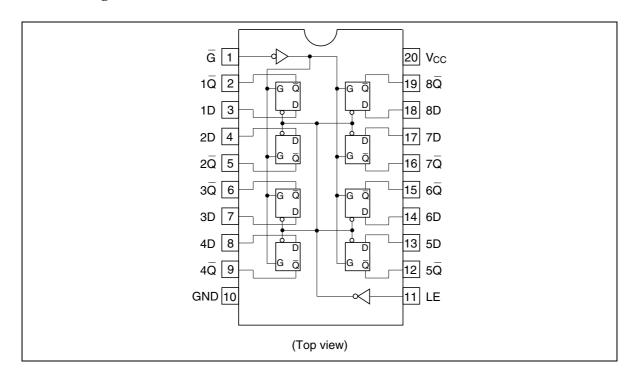
L: Low level

X: Immaterial

Z: High impedance

 Q_0 : Level of \overline{Q} before the indicated steady input conditions were established.

Pin Arrangement



Absolute Maximum Ratings

Item	Symbol	Ratings	Unit	Conditions
Supply voltage	V _{cc}	-0.5 to 6.0	V	
Input diode current	I _{IK}	-50	mA	V ₁ = -0.5 V
Input voltage	V,	-0.5 to 6.0	V	
Output diode current	I _{ok}	-50	mA	V _o = -0.5 V
		50	mA	$V_{o} = V_{cc} + 0.5 \text{ V}$
Output voltage	V _o	-0.5 to V_{cc} +0.5	V	
Output current	I _o	±50	mA	
V _{cc} , GND current / pin	I _{CC} or I _{GND}	100	mA	
Storage temperature	Tstg	-65 to +150	°C	

Note: The absolute maximum ratings are values which must not individually be exceeded, and furthermore, no two of which may be realized at the same time.

Recommended Operating Conditions

Item	Symbol	Ratings	Unit	Conditions
Supply voltage	V _{cc}	1.5 to 5.5	V	Data retention
		2.0 to 5.5	V	At operation
Input / output voltage	V _i	0 to 5.5	V	G, LE, D
	V _o	0 to V _{cc}	V	Q
Operating temperature	Та	-40 to 85	°C	
Output current	I _{OH}	–12	mA	V _{cc} = 2.7 V
		-24 ^{*2}	mA	$V_{cc} = 3.0 \text{ V to } 5.5 \text{ V}$
	I _{oL}	12	mA	V _{cc} = 2.7 V
		24*2	mA	$V_{cc} = 3.0 \text{ V to } 5.5 \text{ V}$
Input rise / fall time *1	t _r , t _f	10	ns/V	

Notes: 1. This item guarantees maximum limit when one input switches.

Waveform : Refer to test circuit of switching characteristics.

2. duty cycle ≤ 50%

Electrical Characteristics

Ta	_	_40	to	85°C	
ıα	=	-4U	ιυ	00 C	

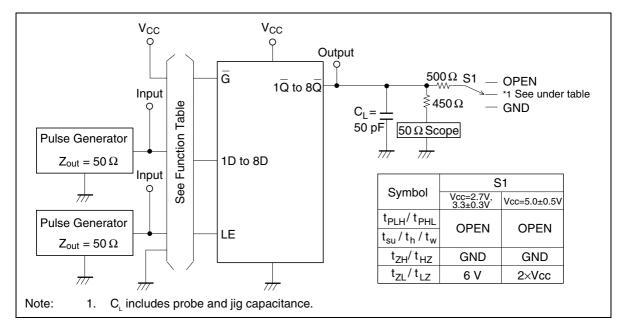
Item	Symbol	V _{cc} (V)	Min	Max	Unit	Test Conditions
Input voltage	V _{IH}	2.7 to 3.6	2.0	_	V	
		4.5 to 5.5	V _{cc} ×0.7	_	V	_
	V _{IL}	2.7 to 3.6	_	0.8	V	
		4.5 to 5.5	_	V _{cc} ×0.3	V	_
Output voltage	V _{OH}	2.7 to 5.5	V _{cc} -0.2	_	V	$I_{OH} = -100 \mu A$
		2.7	2.2	_	V	$I_{OH} = -12 \text{ mA}$
		3.0	2.4	_	V	_
		3.0	2.0	_	V	I _{OH} = -24 mA
		4.5	3.8	_	V	_
	V _{OL}	2.7 to 5.5	_	0.2	V	$I_{OL} = 100 \mu A$
		2.7	_	0.4	V	I _{oL} = 12 mA
		3.0	_	0.55	V	I _{oL} = 24 mA
		4.5	_	0.55	V	_
Input current	I _{IN}	0 to 5.5	_	±5.0	μΑ	V _{IN} = 5.5 V or GND
Off state output current	l _{oz}	5.5	_	±10	μΑ	$V_{IN} = V_{CC}$, GND $V_{OUT} = V_{CC}$ or GND
Quiescent supply current	I _{cc}	5.5	_	20	μΑ	$V_{IN} = V_{CC}$ or GND
	ΔI_{cc}	3.0 to 3.6	_	500	μΑ	V_{IN} = one input at(V_{CC} -0.6)V, other inputs at V_{CC} or GND

Switching Characteristics

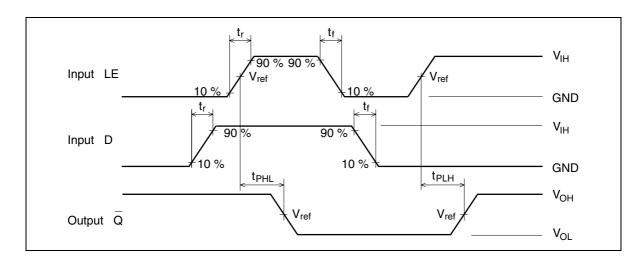
_					
т~	_	<i>1</i> 0	+~	85°C	
17	=	-41	16)	0 20 (.	

Item	Symbol	$V_{cc}(V)$	Min	Тур	Max	Unit	From (Input)	To (Output)
Propagation delay time	t _{PLH}	2.7	_	7.0	9.0	ns	D	Q
	$t_{_{PHL}}$	3.3±0.3	1.5	5.0	8.0	ns	_	
		5.0±0.5	_	4.0	6.5	ns	_	
	t _{PLH}	2.7	_	7.5	10.5	ns	LE	Q
	$t_{_{PHL}}$	3.3±0.3	1.5	5.5	9.5	ns	_	
		5.0±0.5	_	4.0	8.0	ns	_	
Output enable time	t _{zH}	2.7	_	7.5	9.5	ns	G	Q
	$\mathbf{t}_{_{\!\!\!\!\!Z\!$	3.3±0.3	1.5	5.5	8.5	ns	_	
		5.0±0.5	_	4.0	7.0	ns	_	
Output disable time	t _{HZ}	2.7	_	5.0	8.5	ns	G	Q
	$\mathbf{t}_{\scriptscriptstyle LZ}$	3.3±0.3	1.5	4.5	7.5	ns	_	
		5.0±0.5	_	3.5	6.5	ns	_	
Setup time	t _{su}	2.7	2.0	_	_	ns		
		3.3±0.3	2.0	_	_	ns	_	
		5.0±0.5	2.0	_	_	ns	_	
Hold time	t _h	2.7	2.0	_	_	ns		
		3.3±0.3	2.0	_	_	ns	_	
		5.0±0.5	2.0	_	_	ns	_	
Pulse width	t _w	2.7	4.0	_	_	ns		
		3.3±0.3	4.0	_	_	ns	_	
		5.0±0.5	4.0	_	_	ns	_	
Input capacitance	C _{IN}	2.7	_	3.0	_	рF		
Output capacitance	C _o	2.7	_	15.0	_	рF		

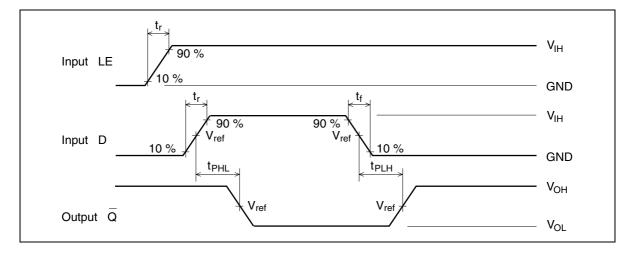
Test Circuit



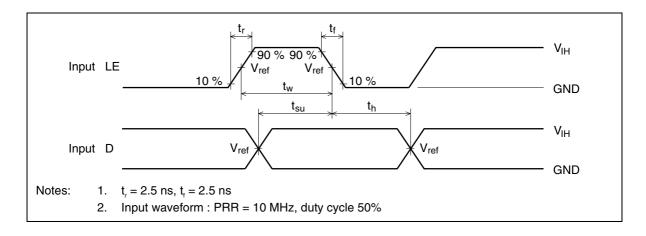
Waveforms - 1



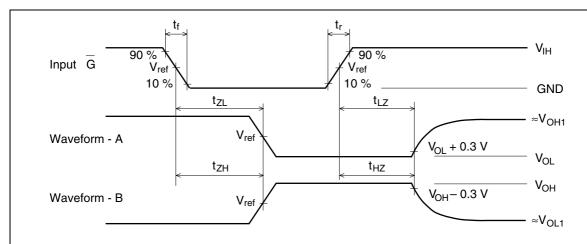
Waveforms - 2



Waveforms - 3



Waveforms - 4

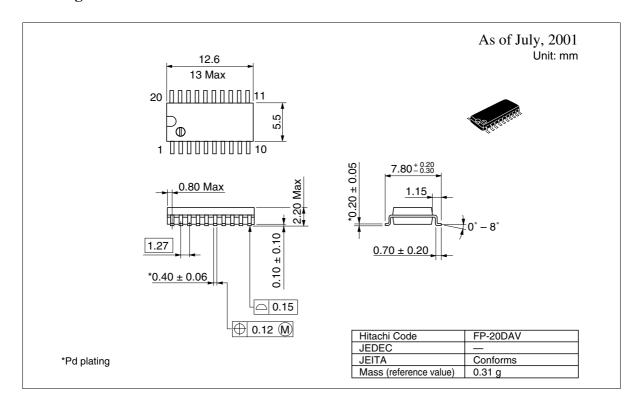


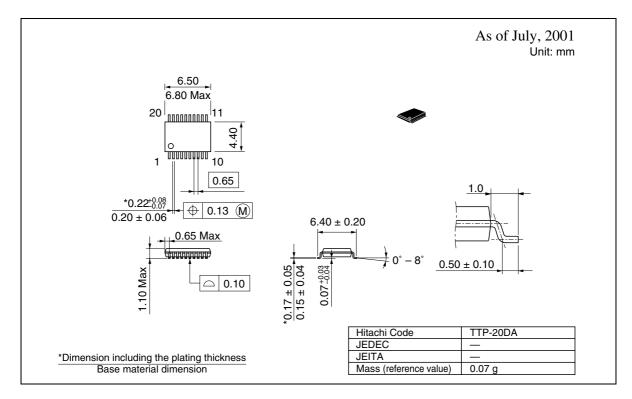
TEST	Vcc=2.7V, 3.3±0.3V	Vcc=5.0±0.5V
V _{IH}	2.7 V	Vcc
V_{ref}	1.5 V	50%Vcc
V _{OH1}	3 V	Vcc
V_{OL1}	GND	GND

Notes:

- 1. $t_r = 2.5 \text{ ns}, t_r = 2.5 \text{ ns}$
- 2. Input waveform: PRR = 10 MHz, duty cycle 50%
- 3. Waveform A shows input conditions such that the output is "L" level when enable by the output control.
- 4. Waveform B shows input conditions such that the output is "H" level when enable by the output control.

Package Dimensions





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